NL3S588

USB 2.0-Capable Ultra-Low THD DPDT Switch

The NL3S588 is a single supply, bidirectional, double−pole/ double−throw (DPDT) switch suitable for both hi−fidelity audio and high−speed data applications.

The NL3S588 features ultra-low distortion, high OFF−Isolation analog switches that can pass analog signals that are positive and negative with respect to ground. It is targeted at consumer and professional DC−coupled GND−referenced audio switching applications such as computer sound cards and home theater products.

The NL3S588 may also be used in high−speed differential data routing applications. Both channels are USB 2.0−compliant.

Features

- DPDT Switch
- 3.3 V Single Supply Operation
- Available in 1.4 mm x 1.8 mm UQFN10
- This Device is Pb−Free, Halogen Free/BFR Free and RoHS Compliant

Audio Capabilities

- 2 V_{RMS} Signal Switching
- −116 dB THD+N into 20 kΩ Load at 2 V_{RMS}
- −112 dB THD+N into 32 Ω Load at 0.707 V_{RMS}
- Signal to Noise Ratio: > 125 dBV
- ±0.004 dB Insertion Loss at 1 kHz, 20 kΩ Load
- ±0.0008 dB Gain Variation 20 Hz to 20 kHz
- 112 dB Signal Muting into 20 kΩ Load
- 131 dB PSRR 20 Hz to 20 kHz

High−Speed Data Capabilities

- Input Signal Range: 0 V to V_{DD}
- C_{ON}: 8.9 pF (Typ)
- Data Rate: USB 2.0–Compliant – up to 480 Mbps
- Bandwidth: 580 MHz

Applications

- Hi−Fi Audio Switching
- USB 2.0 High−Speed Data Switching
- USB 3.x Type C Switching

ON Semiconductor®

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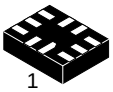
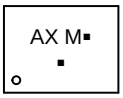
MARKING DIAGRAM



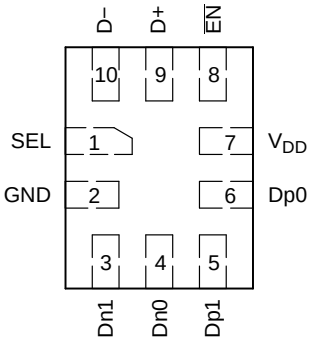
UQFN10
MU SUFFIX
CASE 488AT



AX = Device Code
M = Date Code
▪ = Pb−Free Device

(Note: Microdot may be in either location)

PIN ASSIGNMENT



(Top View)

ORDERING INFORMATION

Device	Package	Shipping†
NL3S588MUTBG	UQFN10 (Pb−Free)	3000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

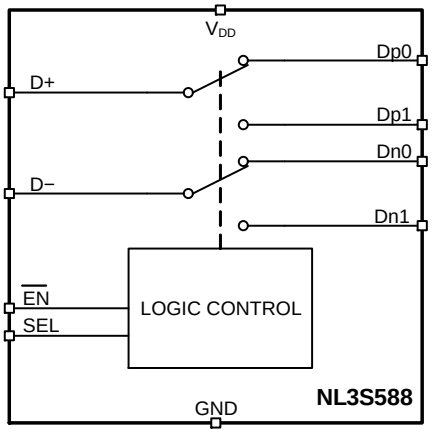


Figure 1. Block Diagram

FUNCTION TABLE

INPUTS		Operating Mode
$\overline{EN}$	SEL	
0	0	Dp0 connected to D+ / Dn0 connected to D−
0	1	Dp1 connected to D+ / Dn1 connected to D−
1	X	Shutdown (I/Os Disconnected)

NOTE: $\overline{EN}$ Logic “0” ≤ 0.5 V, Logic “1” ≥ 1.4 V or float.
SEL Logic “0” ≤ 0.5V, Logic “1” ≥ 1.4 V.
X = Don’t Care

PIN DESCRIPTIONS

PIN NAME	PIN	DESCRIPTION
SEL	1	Channel Select
GND	2	Ground
Dn1	3	Normally−Open I/O
Dp1	5	
Dn0	4	Normally−Closed I/O
Dp0	6	
V_{DD}	7	System power supply pin (+3 V to +3.6 V)
$\overline{EN}$	8	Signal mute control pin
D+	9	Common I/O
D−	10	

MAXIMUM RATINGS

Symbol	Rating	Value	Unit
V_{DD}	Positive 3 V DC Supply Voltage	−0.5 to +4.1	V
V_{IS}	Analog Input/Output Voltage (D+, D−, Dpx, Dnx)	−3.1 to V_{DD} + 0.5	V
V_{IN}	Digital Input Voltage ($\overline{EN}$, SEL)	−0.5 to V_{DD} + 0.5	V
I_{IO}	Switch Continuous Current (D+, D−, Dpx, Dnx)	±300	mA
I_{IO_PK}	Switch Peak Current (D+, D−, Dpx, Dnx) (Pulsed 1 ms, 10% Duty Cycle, Max).	±500	mA
P_D	Power Dissipation in Still Air	800	mW
T_s	Storage Temperature	−65 to +150	°C
T_L	Lead Temperature, 1 mm from Case for 10 seconds	260	°C
T_J	Junction Bias Under Bias	150	°C
θ_{JA}	Thermal Resistance	80	°C/W
T_s	Storage Temperature	−65 to +150	°C
MSL	Moisture Sensitivity	Level 1	
F_R	Flammability Rating — Oxygen Index: 30% − 35%	UL94−V0 (0.125 in)	°C
ESD	ESD Protection — Human Body Model Machine Model	3000 200	V
I_L	Latch−up Current, Above V_{CC} and below GND at 125°C (Note 1)	±300	mA

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.
1. Tested to EIA/JESD78.

RECOMMENDED OPERATING CONDITIONS

Symbol	Parameter	Min	Max	Unit
V_{DD}	Positive DC Supply Voltage	3.0	3.6	V
V_S	Switch Input / Output Voltage (D+, D−, Dpx, Dnx)	−2.9	V_{DD}	V
V_{IN}	Digital Select Input Voltage ($\overline{EN}$, SEL)	GND	V_{DD}	V
T_A	Operating Temperature Range	−40	+85	°C

DC ELECTRICAL CHARACTERISTICS (Voltages referenced to GND): V_{DD} = +3.0 V to +3.6 V, GND = 0 V, V_S = 2 V_{RMS}, R_{LOAD} = 20 kΩ , f = 1 kHz, V_{SELH} = V_{ENH} = 1.4 V, V_{SELL} = V_{ENL} = 0.5 V, (Note 2), Unless otherwise specified.

Parameter	Test Conditions	Supply (V)	Temp (°C)	Min (Notes 3, 4)	Typ	Max (Notes 3, 4)	Units
ANALOG SWITCH CHARACTERISTICS							
Analog Signal Range, V_{ANALOG}		3.3	Full	−	2	−	V_{RMS}
ON−Resistance, r_{ON}	I_{D+} or $I_{D−}$ = 80mA, V_{Dpx} or V_{Dnx} = −2.828 V to +2.828 V (See Figure 5)	3.3	25	−	2.1	−	Ω
			Full	−	2.5	−	
r_{ON} Matching Between Channels, Δr_{ON}	I_{D+} or $I_{D−}$ = 80mA, V_{Dpx} or V_{Dnx} = Voltage at max r_{ON} over −2.828 V to +2.828 V (Note 7)	3.3	25	−	0.046	−	Ω
			Full	−	0.23	−	
r_{ON} Flatness, $r_{FLAT(ON)}$	I_{D+} or $I_{D−}$ = 80mA, V_{Dpx} or V_{Dnx} = −2.828 V, 0V, +2.828 V (Note 5)	3.3	25	−	0.047	0.05	Ω
			Full	−	0.092	−	

2. V_{IN} = input voltage to perform proper function.
3. The algebraic convention, whereby the most negative value is a minimum and the most positive a maximum, is used in this data sheet.
4. Parameters with MIN and/or MAX limits are 100% tested at +25°C, unless otherwise specified. Temperature limits established by characterization and are not production tested.
5. Flatness is defined as the difference between maximum and minimum value of ON−resistance at the specified analog signal voltage points.
6. Limits established by characterization and are not production tested.
7. r_{ON} matching between channels is calculated by subtracting the channel with the highest max r_{ON} value from the channel with lowest max r_{ON} value.
8. Crosstalk is inversely proportional to source impedance.

DC ELECTRICAL CHARACTERISTICS (Voltages referenced to GND): V_{DD} = +3.0 V to +3.6 V, GND = 0 V, V_S = 2 V_{RMS}, R_{LOAD} = 20 kΩ , f = 1 kHz, V_{SELH} = V_{ENH} = 1.4 V, V_{SELL} = V_{ENL} = 0.5 V, (Note 2), Unless otherwise specified.

Parameter	Test Conditions	Supply (V)	Temp (°C)	Min (Notes 3, 4)	Typ	Max (Notes 3, 4)	Units
ANALOG SWITCH CHARACTERISTICS							
D+, D−, Dpx, Dnx Pull−down Resistance	V_{Dpx} or V_{Dnx} = −2.83 V, 2.83 V, V_{D+} or $V_{D−}$ = −2.83 V, 2.83 V, V_{EN} = 3.6 V, measure current, calculate resistance.	3.6	25	225	300	375	kΩ
			Full	−	345	−	
DYNAMIC CHARACTERISTICS							
THD+N	V_S = 2 V_{RMS}, f = 1 kHz, A−weighted filter, R_{LOAD} = 20 kΩ	3.3	25	−	< −116	−	dB
	V_S = 1.9 V_{RMS}, f = 1 kHz, A−weighted filter, R_{LOAD} = 20 kΩ		25	−	< −116	−	
	V_S = 1.8 V_{RMS}, f = 1 kHz, A−weighted filter, R_{LOAD} = 20 kΩ		25	−	< −116	−	
	V_S = 0.707 V_{RMS}, f = 1 kHz, A−weighted filter, R_{LOAD} = 32 Ω		25	−	< −112	−	
SNR	f = 20 Hz to 20 kHz, A−weighted filter, inputs grounded, R_{LOAD} = 20 kΩ or 32 Ω	3.3	25	−	> 125	−	dBV
Insertion Loss, G_{ON}	f = 1 kHz, R_{LOAD} = 20 kΩ	3.3	25	−	±0.004	−	dB
Gain vs Frequency, G_f	f = 20 Hz to 20 kHz, R_{LOAD} = 20 kΩ, reference to G_{ON} at 1 kHz	3.3	25	−	±0.0008	−	dB
Stereo Channel Imbalance Dp0 and Dn0, Dp1 and Dn1	f = 20 Hz to 20 kHz, R_{LOAD} = 20 kΩ	3.3	25	−	±0.0001	−	dB
OFF−Isolation (Disabling)	f = 20 Hz to 22 kHz, D+ = D− = 2 V_{RMS}, R_{LOAD} = 20 kΩ, = 3.3 V, SEL = “X”	3.3	25	−	112	−	dB
	f = 20 Hz to 22 kHz, V_{D+} or $V_{D−}$ = 0.7 V_{RMS}, R_{LOAD} = 32 Ω		25	−	129	−	
Crosstalk (Channel−to− Channel)	R_L = 20 kΩ, f = 20 Hz to 20 kHz, V_S = 2 V_{RMS}, signal source impedance = 20 Ω, (Note 8)	3.3	25	−	102	−	dB
	R_L = 32 Ω, f = 20 Hz to 20 kHz, V_S = 0.7 V_{RMS}, signal source impedance = 20 Ω, (Note 8)		25	−	129	−	
PSRR	f = 1 kHz, V_S = 100 mV_{RMS}, inputs grounded	3.3	25	−	131	−	dB
	f = 20 kHz, V_S = 100 mV_{RMS}, inputs grounded		25	−	133	−	
Bandwidth, −3 dB	R_{LOAD} = 50 Ω	3.3	25	−	580	−	MHz
ON to Disable Time, $T_{TRANS−OM}$		3.3	25	−	250	−	ns
Disable to ON Time, $T_{TRANS−MO}$	V_{IS} = 1.5 V	3.3	25	−	1680	−	μs
Turn−ON Time, t_{ON}	V_{Dpx} or V_{Dnx} = 1.5 V, V_{EN} = 0 V, R_L = 32 Ω (See Figure 2)	3.3	25	−	14	−	μs
Turn−OFF Time, t_{OFF}	V_{Dpx} or V_{Dnx} = 1.5 V, V_{EN} = 0 V, R_L = 32 Ω (See Figure 2)	3.3	25	−	95	−	ns

2. V_{IN} = input voltage to perform proper function.
3. The algebraic convention, whereby the most negative value is a minimum and the most positive a maximum, is used in this data sheet.
4. Parameters with MIN and/or MAX limits are 100% tested at +25°C, unless otherwise specified. Temperature limits established by characterization and are not production tested.
5. Flatness is defined as the difference between maximum and minimum value of ON−resistance at the specified analog signal voltage points.
6. Limits established by characterization and are not production tested.
7. r_{ON} matching between channels is calculated by subtracting the channel with the highest max r_{ON} value from the channel with lowest max r_{ON} value.
8. Crosstalk is inversely proportional to source impedance.

DC ELECTRICAL CHARACTERISTICS (Voltages referenced to GND): V_{DD} = +3.0 V to +3.6 V, GND = 0 V, V_S = 2 V_{RMS}, R_{LOAD} = 20 kΩ , f = 1 kHz, V_{SELH} = V_{ENH} = 1.4 V, V_{SELL} = V_{ENL} = 0.5 V, (Note 2), Unless otherwise specified.

Parameter	Test Conditions	Supply (V)	Temp (°C)	Min (Notes 3, 4)	Typ	Max (Notes 3, 4)	Units
DYNAMIC CHARACTERISTICS							
Break−Before−Make Time Delay, t_D	V_{Dpx} or V_{Dnx} = 1.5V, V_{EN} = 0V, R_L = 32 Ω (See Figure 3)	3.6	25	−	10	−	μs
OFF−Isolation	R_L = 50 Ω, f = 1 MHz, V_{D+} or $V_{D−}$ = 1 V_{RMS} (See Figure 4)	3.3	25	−	70	−	dB
Crosstalk (Channel−to−Channel)	R_L = 50 Ω, f = 1 MHz, V_{D+} or $V_{D−}$ = 1 V_{RMS} (See Figure 4)	3.3	25	−	89	−	dB
Lx, Rx OFF Capacitance, C_{OFF}	f = 1 MHz, V_{Dpx} or V_{Dnx} = V_{D+} or $V_{D−}$ = 0 V (See Figure 7)	3.3	25	−	2.7	−	pF
L, R ON Capacitance, $C_{COM(ON)}$	f = 1 MHz, V_{Dpx} or V_{Dnx} = V_{COM} = 0 V (See Figure 7)	3.3	25	−	8.9	−	pF
Differential Insertion Loss, D_{IL}	f = 10 MHz	3.3	25	−	−0.22	−	dB
	f = 800 MHz	3.3	25	−	−3.3	−	
Differential OFF− Isolation, D_{ISO}	f = 10 MHz	3.3	25	−	−44	−	dB
	f = 800 MHz	3.3	25	−	−16	−	
Differential Crosstalk, D_{CTK}	f = 10 MHz	3.3	25	−	−44	−	dB
	f = 800 MHz	3.3	25	−	−16	−	
POWER SUPPLY CHARACTERISTICS							
Power Supply Range, V_{DD}		3.3	Full	3	−	3.6	V
Positive Supply Current, I+	V_{EN} = 0 V, V_{SEL} = 0 V or V_{DD}	3.6	25	−	54	65	μA
			Full	−	59	−	
	V_{EN} = V_{DD}, V_{SEL} = 0 V or V_{DD}	3.6	25	−	14	40	μA
			Full	−	15	−	
	V_{EN} = 0 V, V_{SEL} = 1.8 V	3.6	25	−	55	65	μA
			Full	−	58	−	

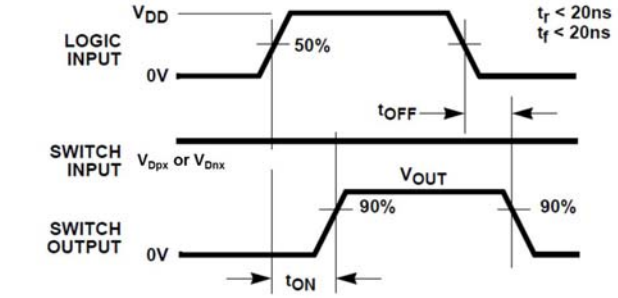
2. V_{IN} = input voltage to perform proper function.
3. The algebraic convention, whereby the most negative value is a minimum and the most positive a maximum, is used in this data sheet.
4. Parameters with MIN and/or MAX limits are 100% tested at +25°C, unless otherwise specified. Temperature limits established by characterization and are not production tested.
5. Flatness is defined as the difference between maximum and minimum value of ON−resistance at the specified analog signal voltage points.
6. Limits established by characterization and are not production tested.
7. r_{ON} matching between channels is calculated by subtracting the channel with the highest max r_{ON} value from the channel with lowest max r_{ON} value.
8. Crosstalk is inversely proportional to source impedance.

DC ELECTRICAL CHARACTERISTICS – Digital Section (Voltages referenced to GND): V_{DD} = +3.0 V to +3.6 V, GND = 0 V, V_S = 2 V_{RMS}, R_{LOAD} = 20 kΩ , f = 1 kHz, V_{SELH} = V_{ENH} = 1.4 V, V_{SELL} = V_{ENL} = 0.5 V, (Note 9), Unless otherwise specified.

Parameter	Test Conditions	Supply (V)	Temp (°C)	Min (Notes 10, 11)	Typ	Max (Notes 10, 11)	Units
DIGITAL INPUT CHARACTERISTICS							
Input Voltage Low, V_{SELL}, V_{ENL}		3.3	Full	−	−	0.5	V
Input Voltage High, V_{SELH}, V_{ENH}		3.3	Full	1.4	−	−	V
Input Current, I_{SELH}, I_{SELL}	V_{EN} = 0 V, V_{SEL} = 0 V or V_{DD}	3.6	Full	−0.5	0.01	0.5	μA
Input Current, I_{ENL}	V_{SEL} = V_{DD}, V_{EN} = 0 V	3.6	Full	−1.3	−0.7	0.3	μA
Input Current, I_{ENH}	V_{SEL} = 0 V, V_{EN} = V_{DD}	3.6	Full	−0.5	0.01	0.5	μA

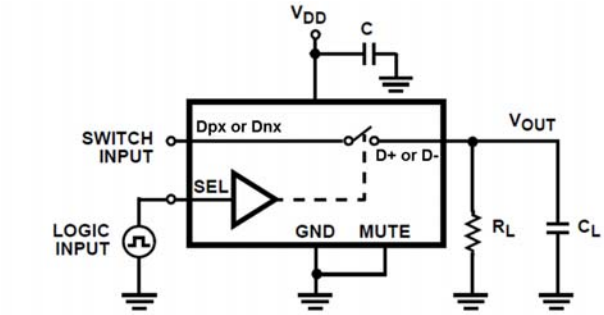
9. V_{IN} = input voltage to perform proper function.
10. The algebraic convention, whereby the most negative value is a minimum and the most positive a maximum, is used in this data sheet.
11. Parameters with MIN and/or MAX limits are 100% tested at +25°C, unless otherwise specified. Temperature limits established by characterization and are not production tested.

TEST CIRCUITS AND WAVEFORMS



Logic input waveform is inverted for switches that have the opposite logic sense.

Measurement Points

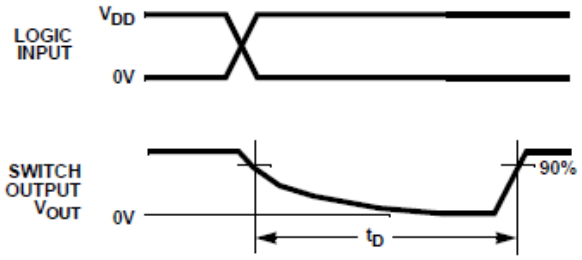


Repeat test for all switches. C_L includes fixture and stray capacitance.

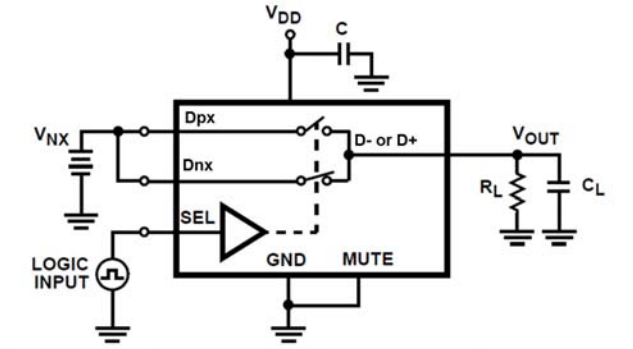
$$V_{OUT} = V_{(Dpx\ or\ Dnx)} \frac{R_L}{R_L + rON}$$

Test Circuit

Figure 2. Switching Times



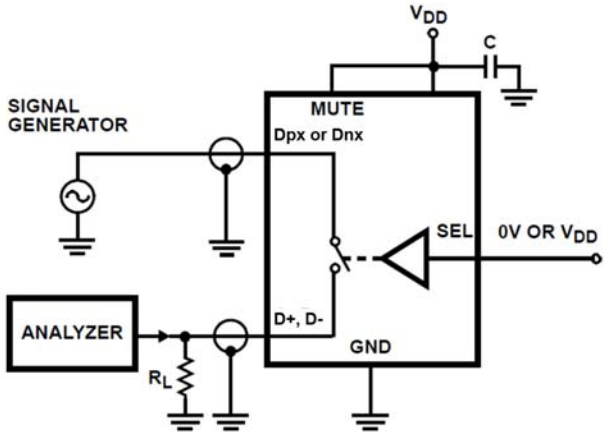
Measurement Points



Repeat test for all switches. C_L includes fixture and stray capacitance.

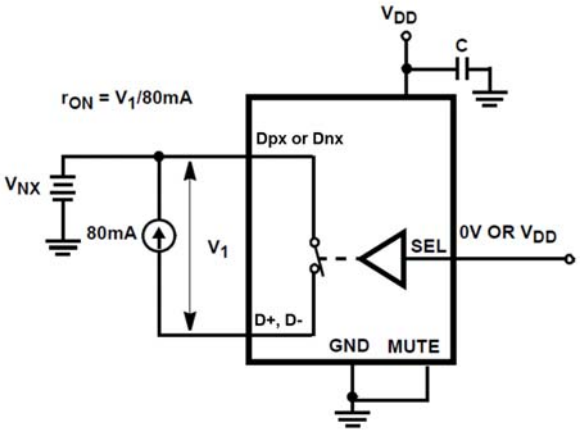
Test Circuit

Figure 3. Break−Before−Make Time



Signal direction through switch is reversed, worst case values are recorded. Repeat test for all switches.

Figure 4. Off−Isolation Test Circuit



Repeat test for all switches.

Figure 5. r_{ON} Test Circuit

TEST CIRCUITS AND WAVEFORMS

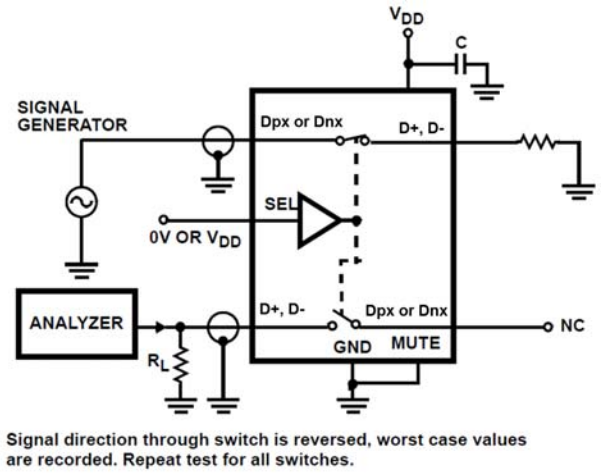


Figure 6. Crosstalk Test Circuit

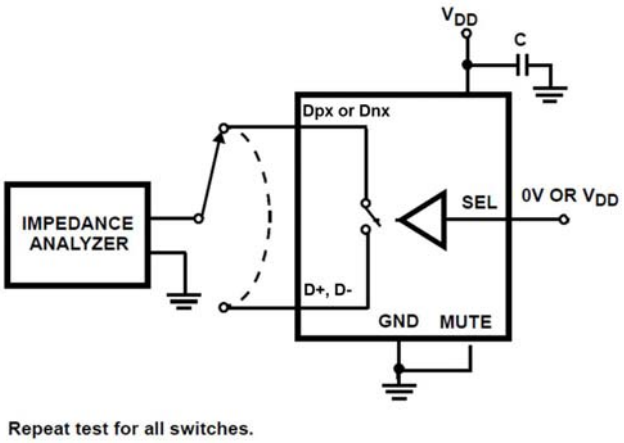


Figure 7. Capacitance Test Circuit

TYPICAL PERFORMANCE CURVES:

T_A = +25°C, Unless Otherwise Specified

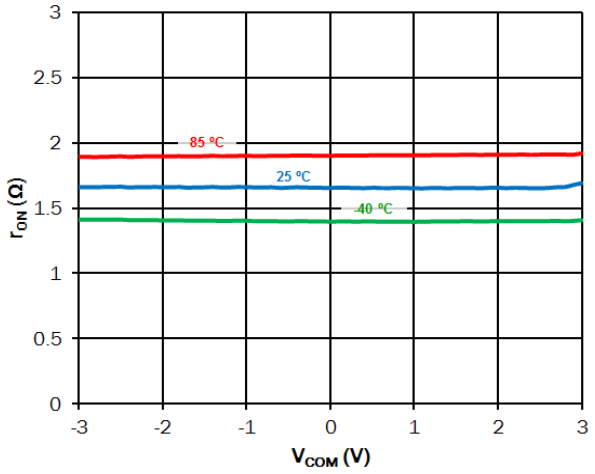


Figure 8. On−Resistance vs. Switch Voltage

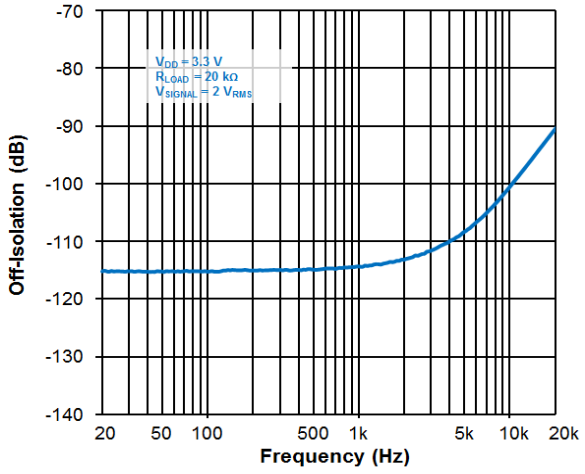


Figure 9. Off−Isolation, 2 V_{RMS} Signal, 20 kΩ Load

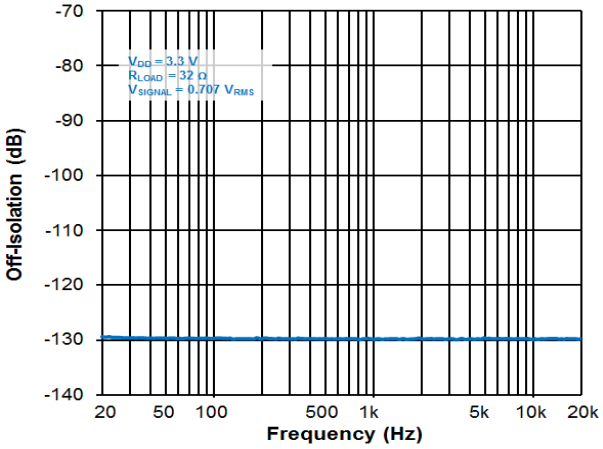


Figure 10. Off−Isolation, 0.707 V_{RMS} Signal, 32 kΩ Load

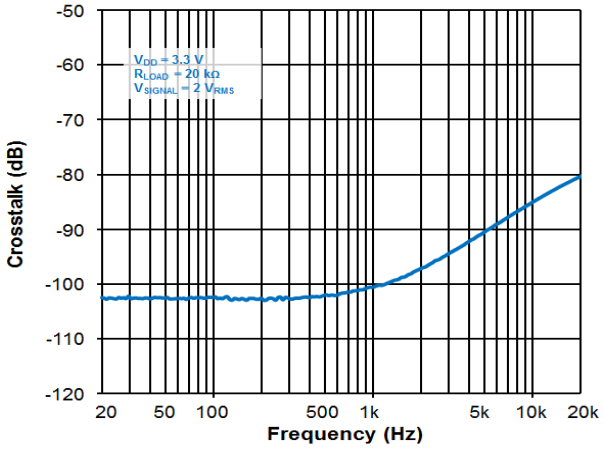


Figure 11. Channel−to−Channel Crosstalk

TYPICAL PERFORMANCE CURVES:

T_A = +25°C, Unless Otherwise Specified

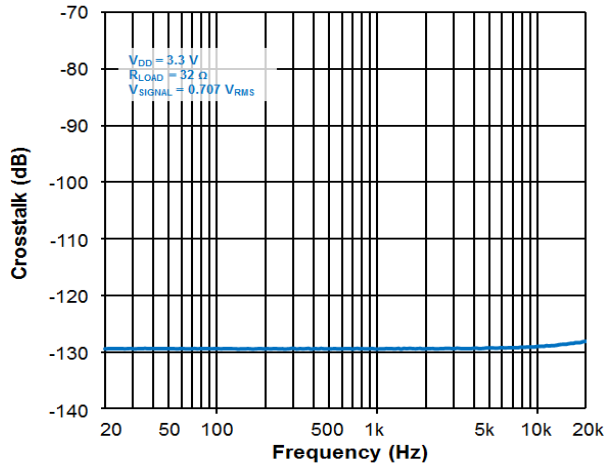


Figure 12. Channel−to−Channel Crosstalk

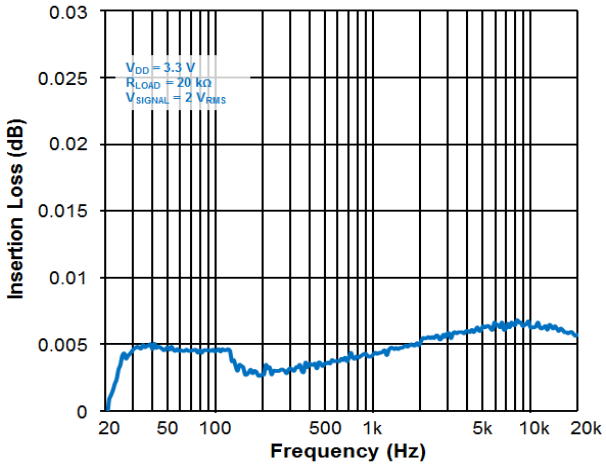


Figure 13. Insertion Loss vs. Frequency

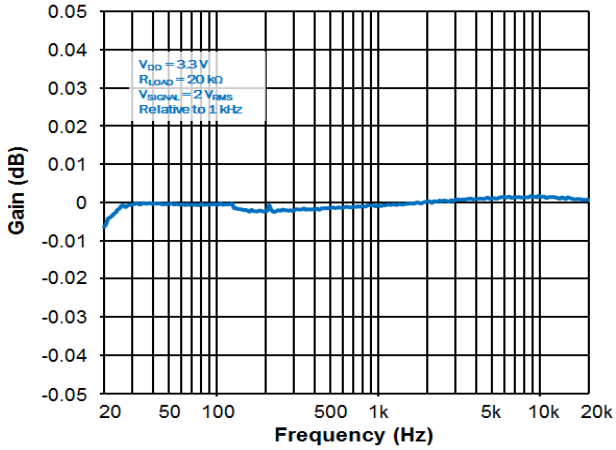


Figure 14. Gain vs. Frequency

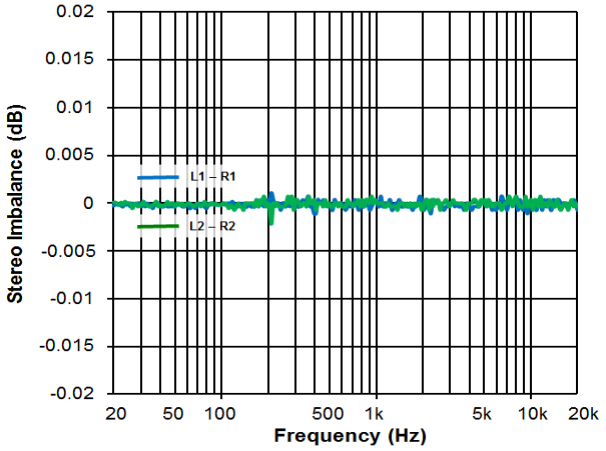


Figure 15. Stereo Imbalance vs. Frequency

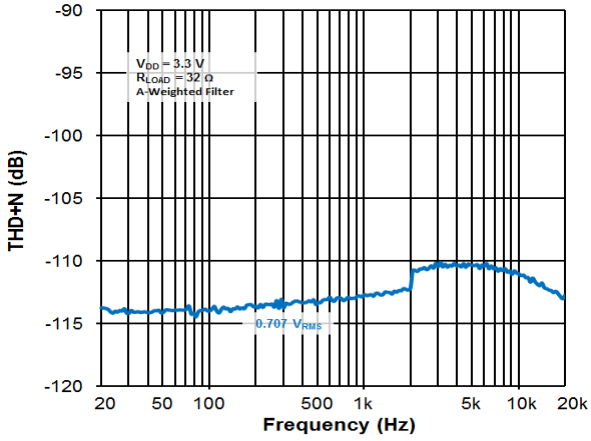


Figure 16. THD+N vs. Signal Levels vs. Frequency

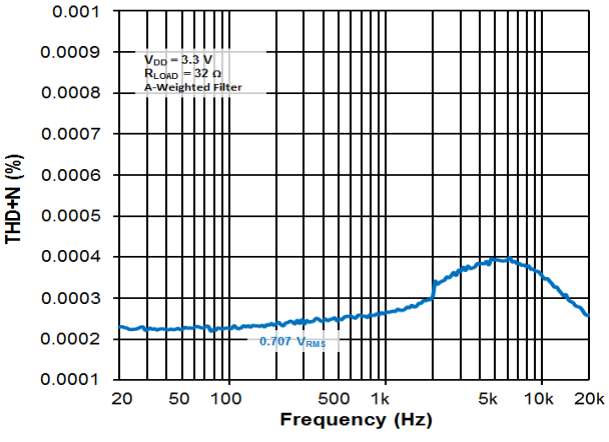


Figure 17. THD+N vs. Signal Levels vs. Frequency

TYPICAL PERFORMANCE CURVES:

T_A = +25°C, Unless Otherwise Specified

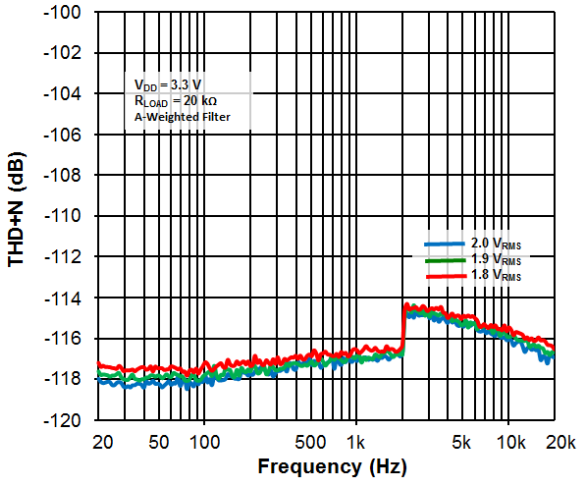


Figure 18. THD+N vs. Signal Levels vs. Frequency

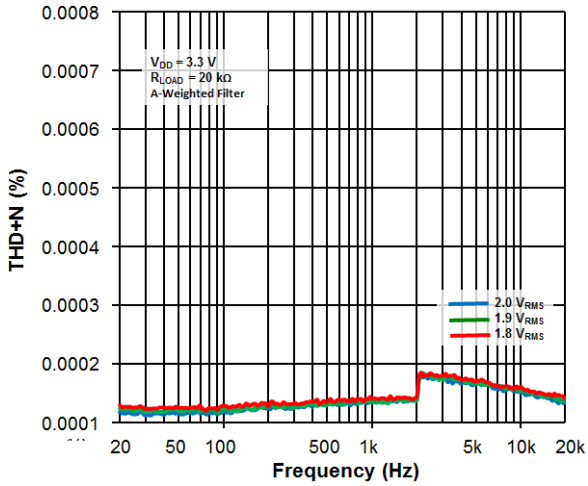


Figure 19. THD+N vs. Signal Levels vs. Frequency

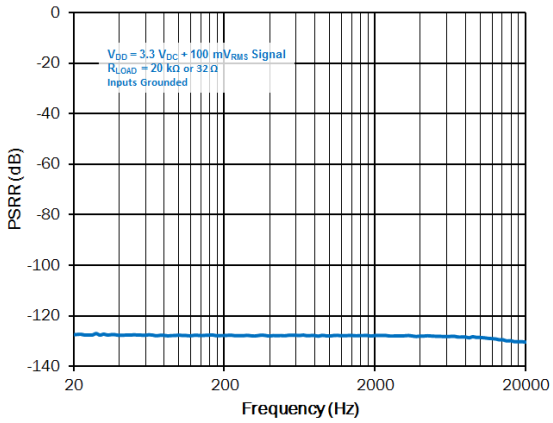


Figure 20. PSRR vs. Frequency

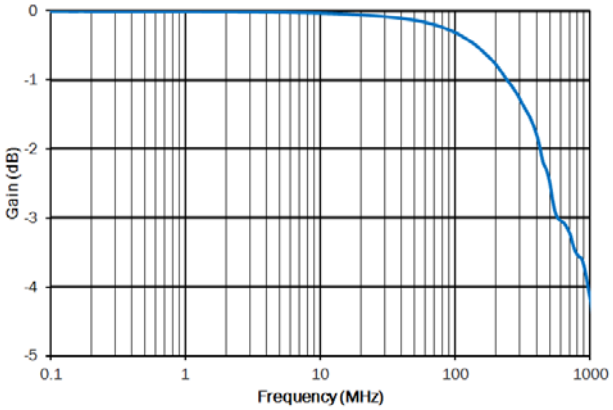


Figure 21. Frequency Response

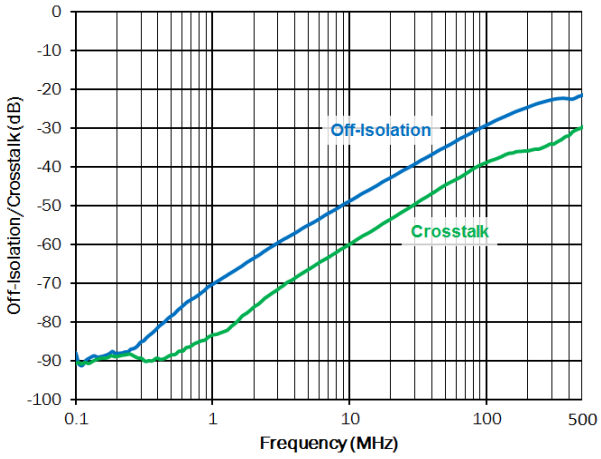


Figure 22. Crosstalk and Off−Isolation

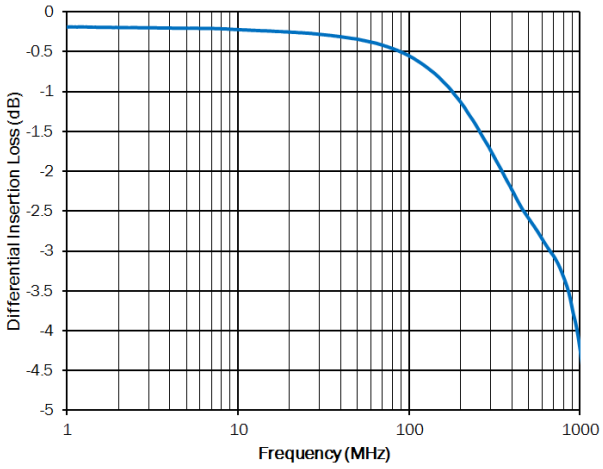


Figure 23. Differential Crosstalk

TYPICAL PERFORMANCE CURVES:

T_A = +25°C, Unless Otherwise Specified

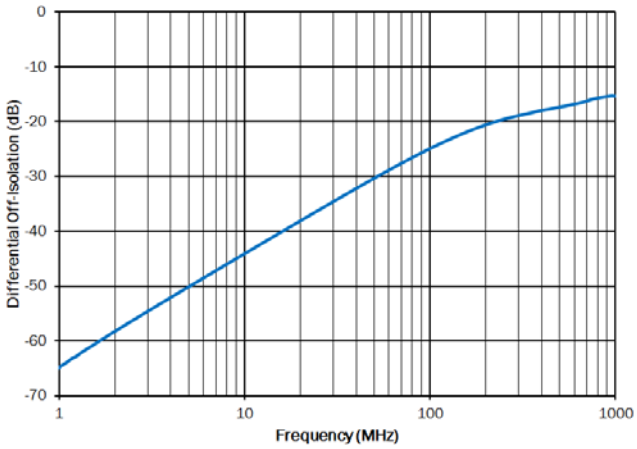


Figure 24. Differential Off−Isolation

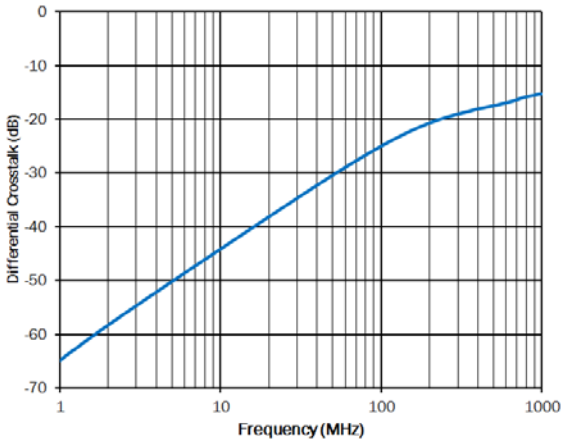


Figure 25. Differential Crosstalk

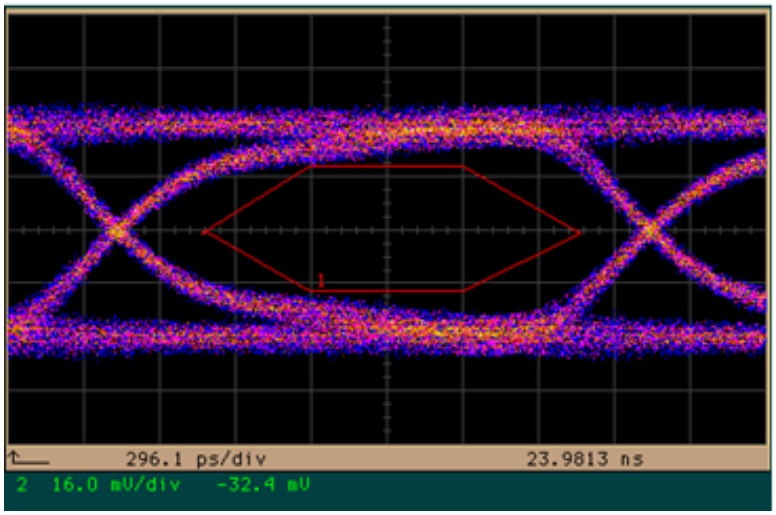
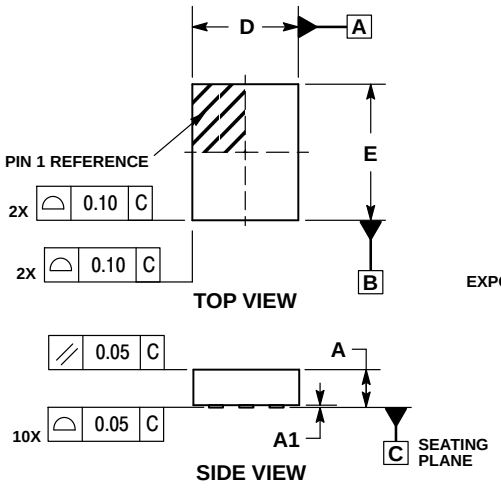


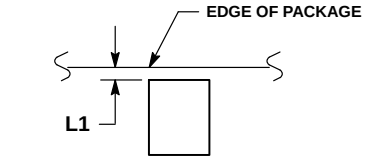
Figure 26. USB 2.0 High−Speed Eye Diagram

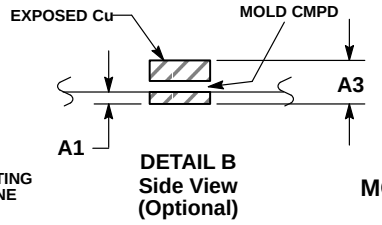
NL3S588

PACKAGE DIMENSIONS

UQFN10 1.4x1.8, 0.4P
CASE 488AT
ISSUE A

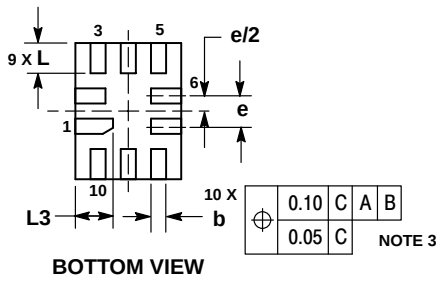




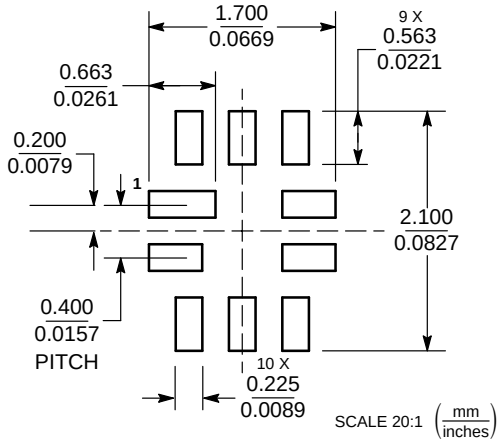


NOTES:
1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETERS
3. DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.25 AND 0.30 MM FROM TERMINAL.
4. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

	MILLIMETERS	
DIM	MIN	MAX
A	0.45	0.60
A1	0.00	0.05
A3	0.127 REF	
b	0.15	0.25
D	1.40 BSC	
E	1.80 BSC	
e	0.40 BSC	
L	0.30	0.50
L1	0.00	0.15
L3	0.40	0.60



MOUNTING FOOTPRINT*



*For additional information on our Pb−Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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